

L Number	Hits	Search Text	DB	Time stamp
-	7289	notch adj2 filter	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:47
-	6073	despread\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:47
-	7937	frequency adj2 hop\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:47
-	20	(notch adj2 filter) and despread\$3 and (frequency adj2 hop\$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:48
-	47343	band adj2 pass adj1 filter	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:48
-	672425	amplifier	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:48
-	2	((notch adj2 filter) same (band adj2 pass adj1 filter) same amplifier) and (frequency adj2 hop\$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:49
-	146	(notch adj2 filter) same (band adj2 pass adj1 filter) same amplifier	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:58
-	3173	rejection adj2 filter	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:58
-	195	(notch adj2 filter) same (rejection adj2 filter)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:58
-	13	(band adj2 pass adj1 filter) same ((notch adj2 filter) same (rejection adj2 filter))	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:00
-	39723	intermediate adj2 frequenc\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:00
-	10129	(notch adj2 filter) or (rejection adj2 filter)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:00
-	378	(intermediate adj2 frequenc\$3) same ((notch adj2 filter) or (rejection adj2 filter))	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:01
-	22	((intermediate adj2 frequenc\$3) same ((notch adj2 filter) or (rejection adj2 filter))) and (frequency adj2 hop\$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:01

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